

Notice of References Cited	Application/Control No. 10/686,396		Applicant(s)/Patent Under Reexamination ISHIHARA, KEIICHIRO	
	Examiner Jonathan R. Beckley		Art Unit 4178	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,180,307 A	12-1979	Tateoka et al.	359/202
*	B	US-4,256,364 A	03-1981	Minoura et al.	359/220
*	C	US-4,314,154 A	02-1982	Minoura et al.	250/235
*	D	US-4,318,582 A	03-1982	Minoura et al.	359/202
*	E	US-4,329,012 A	05-1982	Minoura et al.	359/202
*	F	US-4,327,959 A	05-1982	Minoura et al.	359/210
*	G	US-4,434,659 A	03-1984	Kurtz et al.	73/620
*	H	US-4,872,750 A	10-1989	Morishita, Masanobu	353/7
*	I	US-5,046,795 A	09-1991	Morimoto et al.	359/206
*	J	US-5,067,782 A	11-1991	Morimoto et al.	359/202
*	K	US-5,107,364 A	04-1992	Morimoto et al.	359/212
*	L	US-5,515,122 A	05-1996	Morishima et al.	353/98
*	M	US-5,764,365 A	06-1998	Finarov, Moshe	356/630

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/686,396		Applicant(s)/Patent Under Reexamination ISHIHARA, KEIICHIRO	
	Examiner Jonathan R. Beckley		Art Unit 4178	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,826,961 A	10-1998	Kim et al.	353/74
*	B	US-5,844,713 A	12-1998	Nanba et al.	359/364
*	C	US-5,936,596 A	08-1999	Yoshida et al.	345/9
*	D	US-5,933,280 A	08-1999	Osawa et al.	359/714
*	E	US-6,064,504 A	05-2000	Minakuchi et al.	359/210
*	F	US-6,130,786 A	10-2000	Osawa et al.	359/649
*	G	US-6,137,602 A	10-2000	Mukawa, Hiroshi	359/14
*	H	US-6,219,169 B1	04-2001	Iizuka, Takashi	359/234
*	I	US-6,211,988 B1	04-2001	Engelhardt et al.	359/201
*	J	US-6,232,991 B1	05-2001	Appel, James J.	359/205
*	K	US-6,246,526 B1	06-2001	Okuyama, Atsushi	359/619
*	L	US-6,388,697 B1	05-2002	Sonehara et al.	359/202
*	M	US-2003/0078477 A1	04-2003	Kang et al.	600/178

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/686,396		Applicant(s)/Patent Under Reexamination ISHIHARA, KEIICHIRO	
	Examiner Jonathan R. Beckley		Art Unit 4178	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-RE38,153 E	06-2003	Finarov, Moshe	359/202
*	B	US-6,601,957 B2	08-2003	Sugawara, Saburo	353/82
*	C	US-6,657,763 B2	12-2003	Kobayashi, Shuichi	359/212
*	D	US-6,671,107 B2	12-2003	Chee, Christopher Gregory	359/819
*	E	US-6,698,902 B2	03-2004	Kawano et al.	359/254
*	F	US-2004/0075914 A1	04-2004	Yamamoto, Akira	359/726
*	G	US-2004/0080799 A1	04-2004	Ishihara, Keiichiro	359/202
*	H	US-6,894,746 B1	05-2005	Manabe et al.	349/113
*	I	US-6,985,309 B2	01-2006	Shinohara, Yoshikazu	359/783
*	J	US-7,176,881 B2	02-2007	Nishimura et al.	348/744
*	K	US-7,256,917 B2	08-2007	Ishihara, Keiichiro	359/207
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.